

| | | | |
|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 10/664,921 | Applicant(s)/Patent Under Reexamination ITAKURA ET AL. | |
| | Examiner Lisa Lea-Edmonds | Art Unit 2835 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| | A | US-6,249,432 B1 | 06-2001 | Gamble et al. | 361/685 |
| | B | US-6,371,434 B1 | 04-2002 | Becker et al. | 248/610 |
| | C | US-6,324,054 B1 | 11-2001 | Chee et al. | 361/685 |
| | D | US-6,498,722 B1 | 12-2002 | Stolz et al. | 361/685 |
| | E | US-6,501,644 B1 | 12-2002 | Silverman et al. | 361/685 |
| | F | US-6,545,865 B2 | 04-2003 | Albrecht et al. | 361/685 |
| | G | US-2002/0097556 | 07-2002 | Lee, Jui-Ju | 361/685 |
| | H | US-2002/0154474 | 10-2002 | Merz et al. | 361/683 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.